

Notice of References Cited	Application/Control No. 10/023,123		Applicant(s)/Patent Under Reexamination FUJITA ET AL.	
	Examiner Jacob Meek		Art Unit 2637	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,621,774 A	04-1997	Ishibashi et al.	375/371
*	B	US-6,363,129 B1	03-2002	Agazzi, Oscar E.	375/355
*	C	US-6,526,112 B1	02-2003	Lai, Benny W. H.	375/376
*	D	US-6,552,619 B2	04-2003	Shastri, Kal	331/25
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.